

<b>Notice of References Cited</b>	Application/Control No. 09/849,136	Applicant(s)/Patent Under Reexamination LEE ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-4,397,823	08-1983	Dimpfl, William L.	423/210
	C	US-5,965,786	10-1999	Rostaing et al.	588/210
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	M	US-			

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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